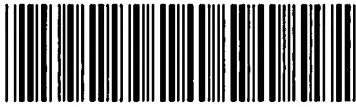


<b>Search Notes</b>  	<b>Application/Control No.</b>  10806064	<b>Applicant(s)/Patent Under Reexamination</b>  SHIN, KYU SHIK
	<b>Examiner</b>  Frantz, Jessica L	<b>Art Unit</b>  3746

SEARCHED			
Class	Subclass	Date	Examiner
417	415	5/4/2007	JF
184	6.5, 6.6, 6.18	5/4/2007	JF

SEARCH NOTES		
Search Notes	Date	Examiner
w/ Chuck Freay (417)	5/3/2007	JF
Text search in East	5/4/2007	JF

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner